Search Notes

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Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,264	EHRLICH, RICHARD M.
Examiner	Art Unit

2651

Natalia Figueroa

SEARCHED				
Class	Subclass	Date	Examiner	
360	65,48-49	3/24/2005	NFM	
360	53,46	3/24/2005	NFM	
360	67,57	3/24/2005	NFM	
360	77.08	3/24/2005	NFM	
360	78.14	3/24/2005	NFM	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	I			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search	3/23/2005	NFM
NPL Search (IEEE Database)	3/23/2005	NFM
NPL Search (JPO Database)	3/23/2005	NFM
Kin Wong	3/23/2005	NFM